

2SB859

Silicon PNP Triple Diffused

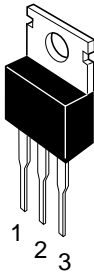
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Application

Low frequency power amplifier complementary pair with 2SD1135

Outline

TO-220AB



1. Base
2. Collector (Flange)
3. Emitter

Absolute Maximum Ratings (Ta = 25°C)

| Item | Symbol | Rating | Unit |
|------------------------------|---------------|-------------|------|
| Collector to base voltage | V_{CBO} | -100 | V |
| Collector to emitter voltage | V_{CEO} | -80 | V |
| Emitter to base voltage | V_{EBO} | -5 | V |
| Collector current | I_C | -4 | A |
| Collector peak current | $I_{C(peak)}$ | -8 | A |
| Collector power dissipation | P_C^{*1} | 40 | W |
| Junction temperature | T_j | 150 | °C |
| Storage temperature | T_{stg} | -45 to +150 | °C |

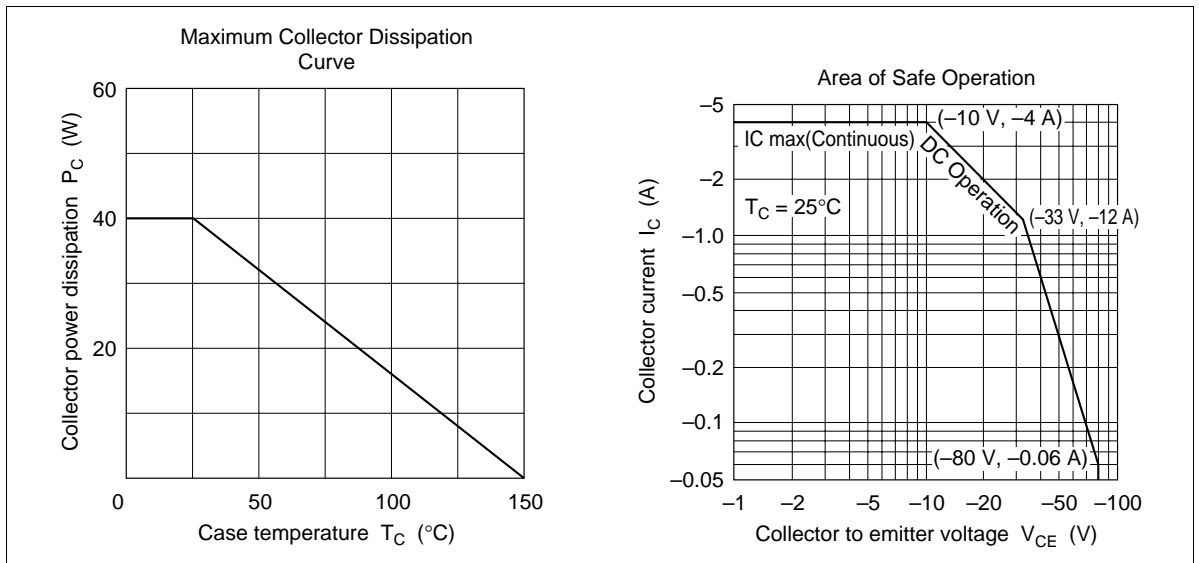
Note: 1. Value at $T_c = 25^\circ\text{C}$

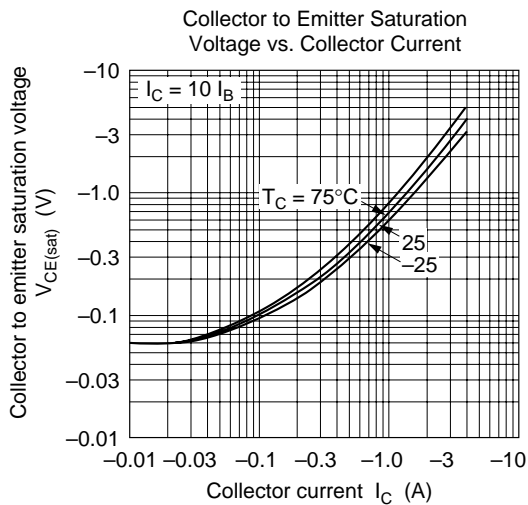
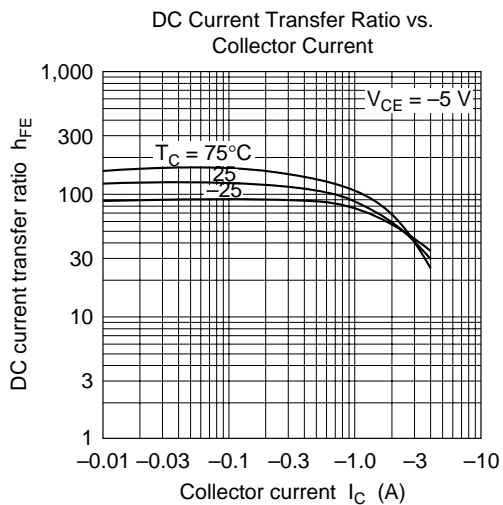
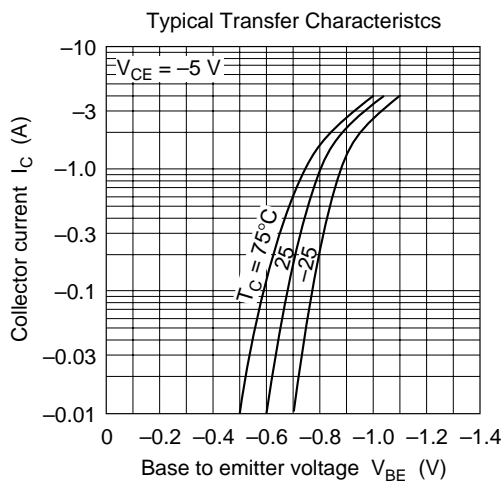
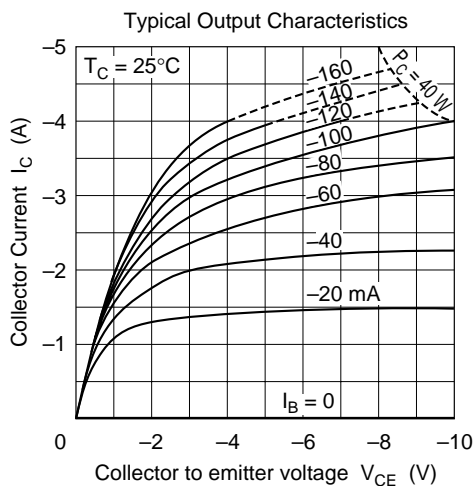
Electrical Characteristics (Ta = 25°C)

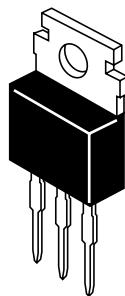
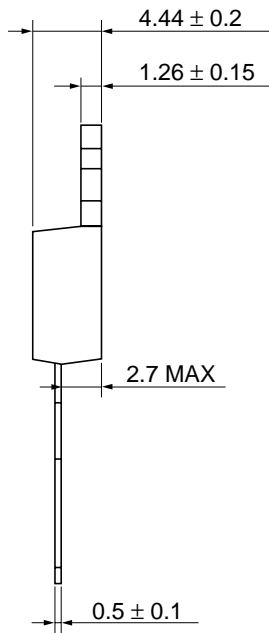
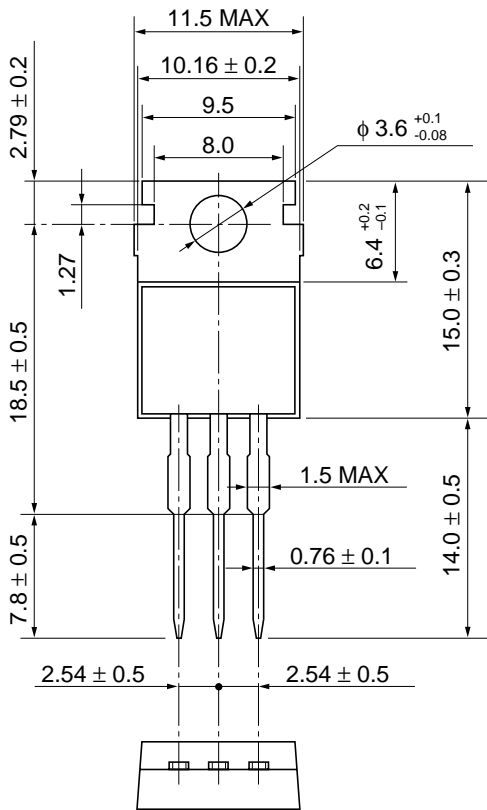
| Item | Symbol | Min | Typ | Max | Unit | Test conditions |
|---|----------------|-----|-----|------|------|--|
| Collector to emitter breakdown voltage | $V_{(BR)CEO}$ | -80 | — | — | V | $I_C = -50 \text{ mA}$, $R_{BE} = \infty$ |
| Emitter to base breakdown voltage | $V_{(BR)EBO}$ | -5 | — | — | V | $I_E = -10 \text{ } \mu\text{A}$, $I_C = 0$ |
| Collector cutoff current | I_{CBO} | — | — | -0.1 | mA | $V_{CB} = -80 \text{ V}$, $I_E = 0$ |
| DC current transfer ratio | h_{FE1}^{*1} | 60 | — | 200 | | $V_{CE} = -5 \text{ V}$, $I_C = -1 \text{ A}^{*2}$ |
| | h_{FE2} | 35 | — | — | | $V_{CE} = -5 \text{ V}$, $I_C = -0.1 \text{ A}^{*2}$ |
| Base to emitter voltage | V_{BE} | — | — | -1.5 | V | $V_{CE} = -5 \text{ V}$, $I_C = -1 \text{ A}^{*2}$ |
| Collector to emitter saturation voltage | $V_{CE(sat)}$ | — | — | -2 | V | $I_C = -2 \text{ A}$, $I_B = -0.2 \text{ A}^{*2}$ |
| Gain bandwidth product | f_T | — | 20 | — | MHz | $V_{CE} = -5 \text{ V}$, $I_C = -0.5 \text{ A}^{*2}$ |
| Collector output capacitance | Cob | — | 75 | — | pF | $V_{CB} = -20 \text{ V}$, $I_E = 0$, $f = 1 \text{ MHz}$ |

Notes: 1. The 2SB859 is grouped by h_{FE1} as follows.
 2. Pulse test

| B | C |
|-----------|------------|
| 60 to 120 | 100 to 200 |







| | |
|--------------------------|----------|
| Hitachi Code | TO-220AB |
| JEDEC | Conforms |
| EIAJ | Conforms |
| Weight (reference value) | 1.8 g |

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